

Notice of References Cited	Application/Control No. 10/618,446	Applicant(s)/Patent Under Reexamination MACGIBBON ET AL.	
	Examiner Michael P. Stafira	Art Unit 2877	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-2002/0145732	10-2002	Vaez-Iravani et al.	356/237.2
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	E	US-2003/0156280	08-2003	Reinhorn, Silviu	356/237.2
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Tetsuya Kawanishi "Brewster's scattering angle and quasi-anomalous scattering in random scattering from dielectric interfaces" Optical Society of America , Vol. 16, No. 2, Feb. 1999.
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.